AN3223K

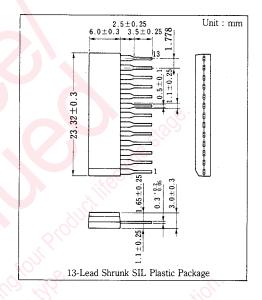
Recording Amplifier Circuit for Video Signal (2-Head Type)

Outline

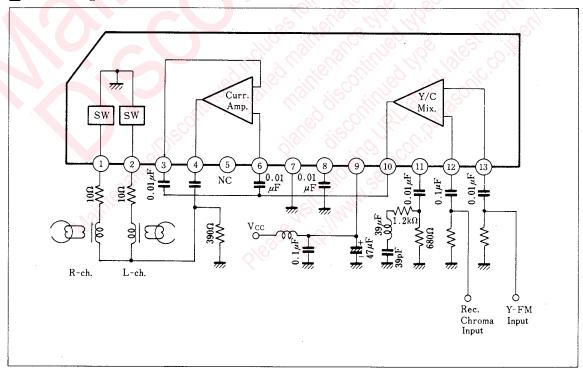
The AN3223K is an integrated circuit designed for recording amplifier circuit for video signal (2-head type).

Features

- Bulit-in switching transistor
- Supply voltage : Vcc=12V



Block Diagram



Pin

Pin No.	Pin Name	Pin No.	Pin Name		
1	ON Switch 1 at Rec.	8	DC Monitor Terminal		
2	ON Switch 2 at Rec.	9	Vcc		
3	Current Amplifier Input	10	Y/C Mix Amplifier Input		
4	Output	11	Gain Control		
5	NC	12	Chrominance Input		
6	Current Amplifier Input	13	Y-FM Input		
7	GND	_	_		

Absolute Maximum Ratings $(Ta=25^{\circ})$

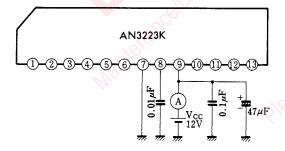
Item	Symbol	Rating	Unit		
Supply Voltage	V _{CC}	14.4	v		
Power Dissipation(Ta=70℃)	P_{D}	600	mW		
Operating Ambient Temperature	$T_{ m opr}$	-20~+70	°C		
Storage Temperature	$T_{\rm stg}$	-55~+155	°C		

Electrical Characteristics $(Ta=25^{\circ})$

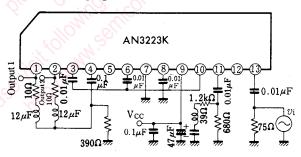
Item	Symbol	Test Circuit	Condition	min.	typ.	max.	Unit
Total Circuit Current	I _{tot}	1	V _{CC} =12.0V	23		41.5	mA
Switching Tr. ON Voltage(I)	v_1	2	$V_{CC}=12.0V, vi=40mv_{P-P}, 4MHz$	68	*	128	mV_{P-P}
Switching Tr. ON Voltage(II)	v_2	2	V _{CC} =12.0V, νi=40mν _{P-P} , 4MHz	68		128	mV_{P-P}
Y Recording Current	I ₄	3	V _{CC} =12.0V, <i>v</i> i=40m <i>v</i> _{P-P} , 4MHz	9.6		17.6	mA _{P-P}
Chroma Recording Current Output	I _{4-C}	4	V _{CC} =12.0V, vi=300mv _{P-P} , 1MHz	5.9	W.	10.7	mA _{P-P}
Recording Current Rated Current Characteristics	I ₄ '/I ₄	3	$V_{CC}=12.0V, vi=40mv_{P-P}, 4MHz$	-0.8	163	0.8	dB
Recording Current Secondary Distortion	D _{2f} *	5	I _{OUT} =15mA _{P-P}	37.1	0	-40	dB
Composite Modulation	CM*	6	$I_{Y(OUT)}=15\text{mA}_{P-P}, I_{OUT} Y/C=10\text{dB}$			-40	dB

Note: Operating Supply Voltage Range: $V_{\text{Coloro}} = 10.8 \sim 13.2 \text{V}$ *It is a reference value but not a guaranteed value.

Test Circuit 1 (I_{tot})



Test Circuit 2 (v_1, v_2)



• Switching Tr. On Voltage (v 1, v 2)

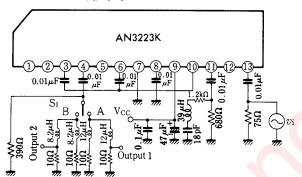
 $V_{CC} = 12V$, $v_i = 4MHz$, $40mV_{P-P}$

Measure voltages of Outputs 1 and 2 at the circuit above.

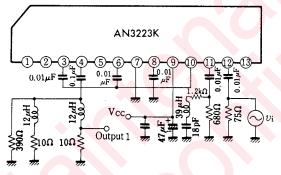
Output 1: *v*1

Output 2: V2

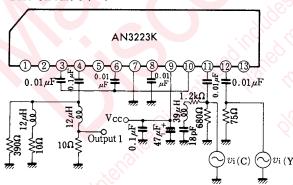
Test Circuit 3 (I₄, I₄'/I₄)



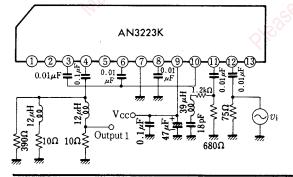
Test Circuit 4 (I₄-C)



Test Circuit 5 (D2f)



Test Circuit 6 (CM)



• Y Recording Current (I4)

 $v_{\rm i}$: 4MHz, 40mV_{P-P}

 V_{CC} : 12V S₁: A

Measure the voltage of Output 1 at the circuit left, and divide it by 10Ω .

• Recording Current Rated Current Characteristics (I4'/I4)

*v*_i : 4MHz V_{CC} : 12V

 $S_1 : B$

Measrue the voltage of Output 2 at the circuit left, and divide it by 10Ω , and compare it to I_4 .

• Chroma Recording Current (I4-c)

vi : 1MHz, 300mV_{P-P}

V_{CC}: 12V

Measure the voltage of Output 1 at the circuit left, and divide it by 10Ω .

• Recording Current Secondary Distortion (D2f)

*v*_i : 4MHz V_{CC} : 12V

Adjust Vi so that Iout is $15mA_{P-P}$ and measure the secondary distortion with the spectrum analyzer.

Composite Demodulation Distortion (CM)

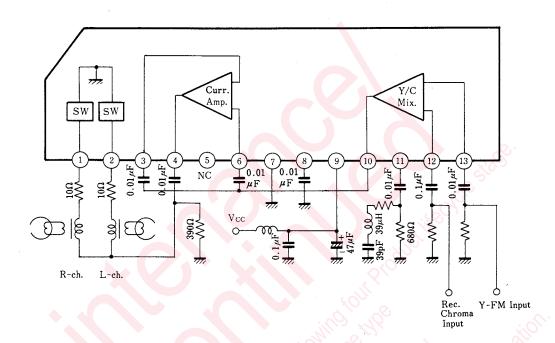
 $fi_{(Y)}$: 4MHz, $fi_{(C)}$: 1MHz

V_{CC} : 12V

• Adjust Vi(Y) so that the recording current output when only Vi(Y) is input becomes $15mA_{P-P}$. Adjust the chroma input so that Iout(Y)/Iout(c) becomes 10dB.

 Measure the composite demodulation (indicating 5MHz element to 4MHz elment).

Application Circuit



Request for your special attention and precautions in using the technical information and semiconductors described in this book

- (1) If any of the products or technical information described in this book is to be exported or provided to non-residents, the laws and regulations of the exporting country, especially, those with regard to security export control, must be observed.
- (2) The technical information described in this book is intended only to show the main characteristics and application circuit examples of the products. No license is granted in and to any intellectual property right or other right owned by Panasonic Corporation or any other company. Therefore, no responsibility is assumed by our company as to the infringement upon any such right owned by any other company which may arise as a result of the use of technical information described in this book.
- (3) The products described in this book are intended to be used for standard applications or general electronic equipment (such as office equipment, communications equipment, measuring instruments and household appliances).
 - Consult our sales staff in advance for information on the following applications:
 - Special applications (such as for airplanes, aerospace, automobiles, traffic control equipment, combustion equipment, life support systems and safety devices) in which exceptional quality and reliability are required, or if the failure or malfunction of the products may directly jeopardize life or harm the human body.
 - · Any applications other than the standard applications intended.
- (4) The products and product specifications described in this book are subject to change without notice for modification and/or improvement. At the final stage of your design, purchasing, or use of the products, therefore, ask for the most up-to-date Product Standards in advance to make sure that the latest specifications satisfy your requirements.
- (5) When designing your equipment, comply with the range of absolute maximum rating and the guaranteed operating conditions (operating power supply voltage and operating environment etc.). Especially, please be careful not to exceed the range of absolute maximum rating on the transient state, such as power-on, power-off and mode-switching. Otherwise, we will not be liable for any defect which may arise later in your equipment.
- Even when the products are used within the guaranteed values, take into the consideration of incidence of break down and failure mode, possible to occur to semiconductor products. Measures on the systems such as redundant design, arresting the spread of fire or preventing glitch are recommended in order to prevent physical injury, fire, social damages, for example, by using the products.
- (6) Comply with the instructions for use in order to prevent breakdown and characteristics change due to external factors (ESD, EOS, thermal stress and mechanical stress) at the time of handling, mounting or at customer's process. When using products for which damp-proof packing is required, satisfy the conditions, such as shelf life and the elapsed time since first opening the packages.
- (7) This book may be not reprinted or reproduced whether wholly or partially, without the prior written permission of our company.

20080805